

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/721,687 | Applicant(s)/Patent Under Reexamination LANG, DAVID DELL | |
| | Examiner Mark S. Graham | Art Unit 3711 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | A | US-6,712,721 B2 | 03-2004 | Buzak et al. | 473/411 |
| | B | US-6,099,139 A | 08-2000 | Lapensee, Martin Eric | 362/153.1 |
| | C | US-5,265,875 A | 11-1993 | Fitzgerald, John H. | 473/169 |
| | D | US-6,758,767 B1 | 07-2004 | Wang, Andrew | 473/410 |
| | E | US- | | | |
| | F | US-161,080 | 03-1875 | West | 473/411 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-------------|----------------|
| | N | JP 10118231 A | 05-1998 | Japan | OTA, TERUMI | A63B 63/00 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.